

74LCX841

Low Voltage 10-Bit Transparent Latch with 5V Tolerant Inputs and Outputs

General Description

The LCX841 consists of ten latches with 3-STATE outputs for bus organized system applications. The device is designed for low voltage (2.5V or 3.3V) V_{CC} applications with capability of interfacing to a 5V signal environment.

The LCX841 is fabricated with an advanced CMOS technology to achieve high speed operation while maintaining CMOS low power dissipation.

Features

- 5V tolerant inputs and outputs
- 2.3V – 3.6V V_{CC} specifications provided
- 8.0 ns t_{PD} max ($V_{CC} = 3.3V$), 10 μA I_{CC} max
- Power-down high impedance inputs and outputs
- Supports live insertion/withdrawal (Note 1)
- ± 24 mA output drive ($V_{CC} = 3.0V$)
- Implements patented noise/EMI reduction circuitry
- Latch-up performance exceeds 500 mA
- ESD performance:
 - Human Body Model > 2000V
 - Machine Model > 200V

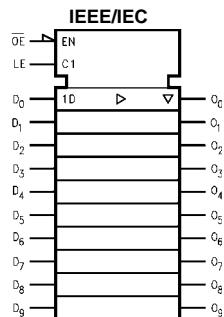
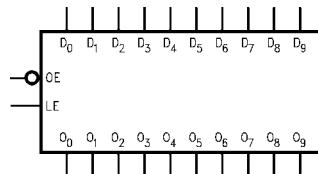
Note 1: To ensure the high-impedance state during power up or down, \overline{OE} should be tied to V_{CC} through a pull-up resistor: the minimum value or the resistor is determined by the current-sourcing capability of the driver.

Ordering Code:

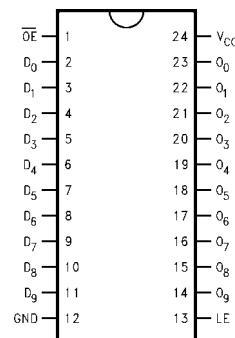
| Order Number | Package Number | Package Description |
|--------------|----------------|---|
| 74LCX841VM | M24B | 24-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide |
| 74LCX841MSA | MSA24 | 24-Lead Shrink Small Outline Package (SSOP), EIAJ TYPE II, 5.3mm Wide |
| 74LCX841MTC | MTC24 | 24-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide |

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbols



Connection Diagram



Pin Descriptions

| Pin Names | Description |
|------------|-----------------------|
| D_0-D_9 | Data Inputs |
| LE | Latch Enable Input |
| \bar{OE} | Output Enable Input |
| O_0-O_9 | 3-STATE Latch Outputs |

Truth Table

| Function | Inputs | | | Internal | Output |
|-------------|------------|----|---|----------|--------|
| | \bar{OE} | LE | D | Q | O |
| High Z | X | X | X | X | Z |
| High Z | H | H | L | L | Z |
| High Z | H | H | H | H | Z |
| Latched | H | L | X | NC | Z |
| Transparent | L | H | L | L | L |
| Transparent | L | H | H | H | H |
| Latched | L | L | X | NC | NC |

H = HIGH Voltage Level

L = LOW Voltage Level

X = Immaterial

Z = High Impedance

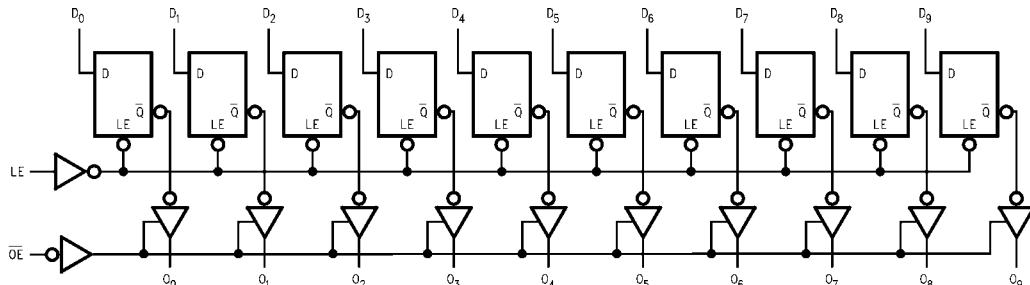
NC = No Change

Functional Description

The LCX841 consists of ten D-type latches with 3-STATE outputs. The flip-flops appear transparent to the data when Latch Enable (LE) is HIGH. This allows asynchronous operation, as the output transition follows the data in transition.

On the LE HIGH-to-LOW transition, the data that meets the setup and hold time is latched. Data appears on the bus when the Output Enable (\bar{OE}) is LOW. When \bar{OE} is HIGH the bus output is in the high impedance state.

Logic Diagram



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Absolute Maximum Ratings (Note 2)

| Symbol | Parameter | Value | Conditions | Units |
|-----------|----------------------------------|--|---|-------------|
| V_{CC} | Supply Voltage | -0.5 to +7.0 | | V |
| V_I | DC Input Voltage | -0.5 to +7.0 | | V |
| V_O | DC Output Voltage | -0.5 to +7.0 -0.5 to V_{CC} + 0.5 | Output in 3-STATE Output in HIGH or LOW State (Note 3) | V |
| I_{IK} | DC Input Diode Current | -50 | $V_I < GND$ | mA |
| I_{OK} | DC Output Diode Current | -50 +50 | $V_O < GND$ $V_O > V_{CC}$ | mA |
| I_O | DC Output Source/Sink Current | ± 50 | | mA |
| I_{CC} | DC Supply Current per Supply Pin | ± 100 | | mA |
| I_{GND} | DC Ground Current per Ground Pin | ± 100 | | mA |
| T_{STG} | Storage Temperature | -65 to +150 | | $^{\circ}C$ |

Recommended Operating Conditions (Note 4)

| Symbol | Parameter | | Min | Max | Units |
|---------------------|---|--|--------|---------------------------------|-------------|
| V_{CC} | Supply Voltage | Operating | 2.0 | 3.6 | V |
| | | Data Retention | 1.5 | 3.6 | |
| V_I | Input Voltage | | 0 | 5.5 | V |
| V_O | Output Voltage | HIGH or LOW State 3-STATE | 0 0 | V_{CC} 5.5 | V |
| I_{OH}/I_{OL} | Output Current | $V_{CC} = 3.0V - 3.6V$ $V_{CC} = 2.7V - 3.0V$ $V_{CC} = 2.3V - 2.7V$ | | ± 24 ± 12 ± 8 | mA |
| T_A | Free-Air Operating Temperature | | -40 | 85 | $^{\circ}C$ |
| $\Delta t/\Delta V$ | Input Edge Rate, $V_{IN} = 0.8V - 2.0V$, $V_{CC} = 3.0V$ | | 0 | 10 | ns/V |

Note 2: The Absolute Maximum Ratings are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the Absolute Maximum Ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

Note 3: I_O Absolute Maximum Rating must be observed.

Note 4: Unused inputs must be held HIGH or LOW. They may not float.

DC Electrical Characteristics

| Symbol | Parameter | Conditions | V_{CC} (V) | $T_A = -40^{\circ}C$ to $+85^{\circ}C$ | | Units |
|-----------|---------------------------|--|------------------------|--|------------|---------|
| | | | | Min | Max | |
| V_{IH} | HIGH Level Input Voltage | | 2.3 - 2.7 2.7 - 3.6 | 1.7 2.0 | | V |
| V_{IL} | LOW Level Input Voltage | | 2.3 - 2.7 2.7 - 3.6 | | 0.7 0.8 | V |
| V_{OH} | HIGH Level Output Voltage | $I_{OH} = -100 \mu A$ | 2.3 - 3.6 | $V_{CC} - 0.2$ | | V |
| | | $I_{OH} = -8 mA$ | 2.3 | 1.8 | | |
| | | $I_{OH} = -12 mA$ | 2.7 | 2.2 | | |
| | | $I_{OH} = -18 mA$ | 3.0 | 2.4 | | |
| | | $I_{OH} = -24 mA$ | 3.0 | 2.2 | | |
| V_{OL} | LOW Level Output Voltage | $I_{OL} = 100 \mu A$ | 2.3 - 3.6 | | 0.2 | V |
| | | $I_{OL} = 8 mA$ | 2.3 | | 0.6 | |
| | | $I_{OL} = 12 mA$ | 2.7 | | 0.4 | |
| | | $I_{OL} = 16 mA$ | 3.0 | | 0.4 | |
| | | $I_{OL} = 24 mA$ | 3.0 | | 0.55 | |
| I_I | Input Leakage Current | $0 \leq V_I \leq 5.5V$ | 2.3 - 3.6 | | ± 5.0 | μA |
| I_{OZ} | 3-STATE Output Leakage | $0 \leq V_O \leq 5.5V$ $V_I = V_{IH}$ or V_{IL} | 2.3 - 3.6 | | ± 5.0 | μA |
| I_{OFF} | Power-Off Leakage Current | V_I or $V_O = 5.5V$ | 0 | | 10 | μA |

DC Electrical Characteristics (Continued)

| Symbol | Parameter | Conditions | V _{CC} (V) | T _A = -40°C to +85°C | | Units |
|------------------|---------------------------------------|--|------------------------|---------------------------------|-----|-------|
| | | | | Min | Max | |
| I _{CC} | Quiescent Supply Current | V _I = V _{CC} or GND | 2.3 – 3.6 | | 10 | μA |
| | | 3.6V ≤ V _I , V _O ≤ 5.5V (Note 5) | 2.3 – 3.6 | | ±10 | |
| ΔI _{CC} | Increase in I _{CC} per Input | V _{IH} = V _{CC} – 0.6V | | 2.3 – 3.6 | 500 | μA |

Note 5: Outputs disabled or 3-STATE only.

AC Electrical Characteristics

| Symbol | Parameter | T _A = -40°C to +85°C, R _L = 500Ω | | | | | | Units | |
|-------------------|--|--|-----|------------------------|-----|-------------------------------|-----|-------|--|
| | | V _{CC} = 3.3V ± 0.3V | | V _{CC} = 2.7V | | V _{CC} = 2.5V ± 0.2V | | | |
| | | C _L = 50 pF | | C _L = 50 pF | | C _L = 30 pF | | | |
| | | Min | Max | Min | Max | Min | Max | | |
| t _{PHL} | Propagation Delay D _n to O _n | 1.5 | 7.0 | 1.5 | 7.5 | 1.5 | 8.4 | ns | |
| t _{PLH} | Propagation Delay LE to O _n | 1.5 | 7.0 | 1.5 | 7.5 | 1.5 | 8.4 | ns | |
| t _{PZL} | Output Enable Time | 1.5 | 8.0 | 1.5 | 8.5 | 1.5 | 9.6 | ns | |
| t _{PZH} | | 1.5 | 8.0 | 1.5 | 8.5 | 1.5 | 9.6 | ns | |
| t _{PLZ} | Output Disable Time | 1.5 | 6.5 | 1.5 | 7.0 | 1.5 | 7.8 | ns | |
| t _{PHZ} | | 1.5 | 6.5 | 1.5 | 7.0 | 1.5 | 7.8 | ns | |
| t _{OSHL} | Output to Output Skew (Note 6) | | 1.0 | | | | | ns | |
| t _{OSLH} | | | 1.0 | | | | | ns | |
| t _S | Setup Time D _n to LE | 2.5 | | 2.5 | | 4.0 | | ns | |
| t _H | Hold Time D _n to LE | 1.5 | | 1.5 | | 2.0 | | ns | |
| t _W | LE Pulse Width | 3.3 | | 3.3 | | 4.0 | | ns | |

Note 6: Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH-to-LOW (t_{OSHL}) or LOW-to-HIGH (t_{OSLH}).

Dynamic Switching Characteristics

| Symbol | Parameter | Conditions | V _{CC} (V) | T _A = 25°C | | Units |
|------------------|---|--|------------------------|-----------------------|---|-------|
| | | | | Typical | | |
| V _{OLP} | Quiet Output Dynamic Peak V _{OL} | C _L = 50 pF, V _{IH} = 3.3V, V _{IL} = 0V | 3.3 | 0.8 | V | |
| | | C _L = 30 pF, V _{IH} = 2.5V, V _{IL} = 0V | 2.5 | 0.6 | | |
| V _{OLV} | Quiet Output Dynamic Valley V _{OL} | C _L = 50 pF, V _{IH} = 3.3V, V _{IL} = 0V | 3.3 | -0.8 | V | |
| | | C _L = 30 pF, V _{IH} = 2.5V, V _{IL} = 0V | 2.5 | -0.6 | | |

Capacitance

| Symbol | Parameter | Conditions | Typical | Units |
|-----------------|-------------------------------|---|---------|-------|
| C _{IN} | Input Capacitance | V _{CC} = Open, V _I = 0V or V _{CC} | 7 | pF |
| C _O | Output Capacitance | V _{CC} = 3.3V, V _I = 0V or V _{CC} | 8 | pF |
| C _{PD} | Power Dissipation Capacitance | V _{CC} = 3.3V, V _I = 0V or V _{CC} , f = 10 MHz | 20 | pF |

AC LOADING and WAVEFORMS Generic for LCX Family

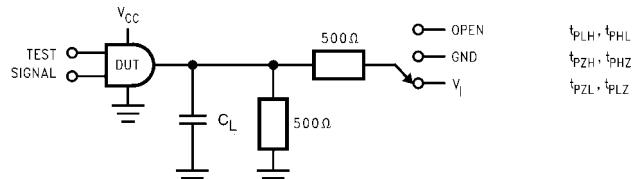
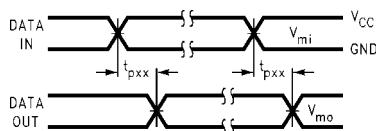
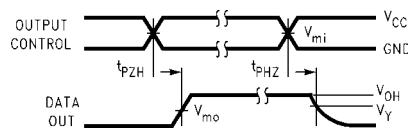


FIGURE 1. AC Test Circuit (C_L includes probe and jig capacitance)

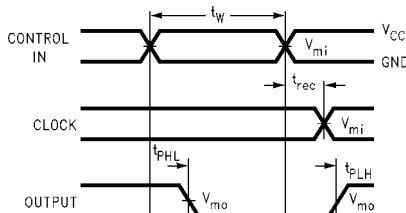
| Test | Switch |
|--------------------|--|
| t_{PLH}, t_{PHL} | Open |
| t_{PZH}, t_{PHZ} | 6V at $V_{CC} = 3.3 \pm 0.3V$ |
| t_{PZL}, t_{PLZ} | $V_{CC} \times 2$ at $V_{CC} = 2.5 \pm 0.2V$ |



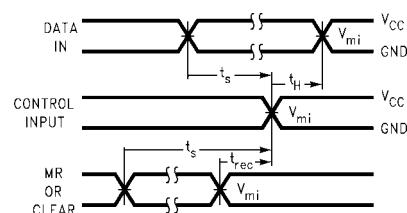
Waveform for Inverting and Non-Inverting Functions



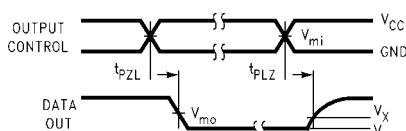
3-STATE Output High Enable and Disable Times for Logic



Propagation Delay, Pulse Width and t_{rec} Waveforms



Setup Time, Hold Time and Recovery Time for Logic



3-STATE Output Low Enable and Disable Times for Logic

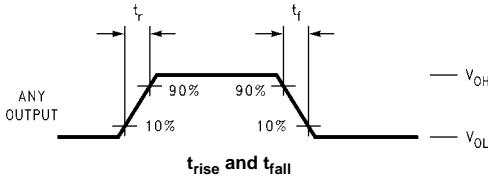
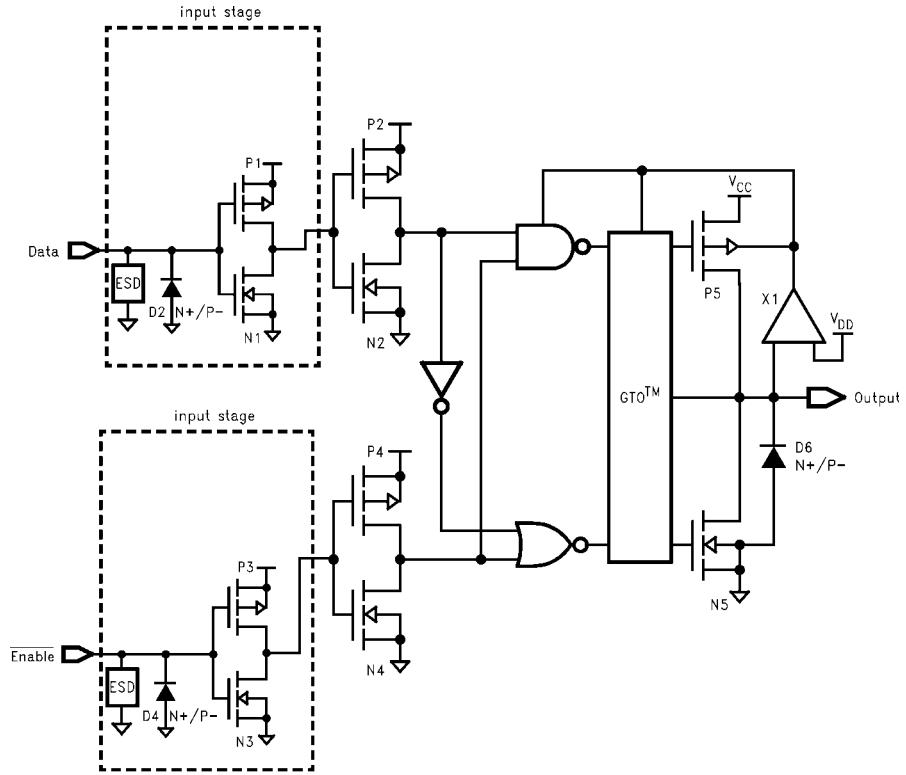


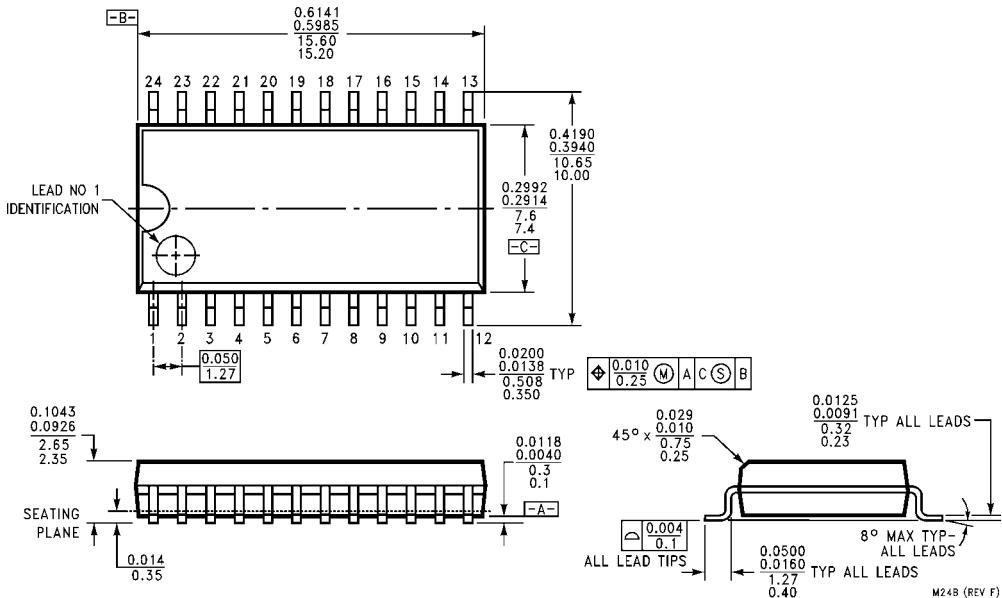
FIGURE 2. Waveforms
(Input Characteristics; f = 1MHz, t_r = t_f = 3ns)

| Symbol | V _{CC} | | |
|-----------------|-----------------|-----------------|------------------|
| | 3.3V \pm 0.3V | 2.7V | 2.5V \pm 0.2V |
| V _{mi} | 1.5V | 1.5V | $V_{CC}/2$ |
| V _{mo} | 1.5V | 1.5V | $V_{CC}/2$ |
| V _x | $V_{OL} + 0.3V$ | $V_{OL} + 0.3V$ | $V_{OL} + 0.15V$ |
| V _y | $V_{OH} - 0.3V$ | $V_{OH} - 0.3V$ | $V_{OH} - 0.15V$ |

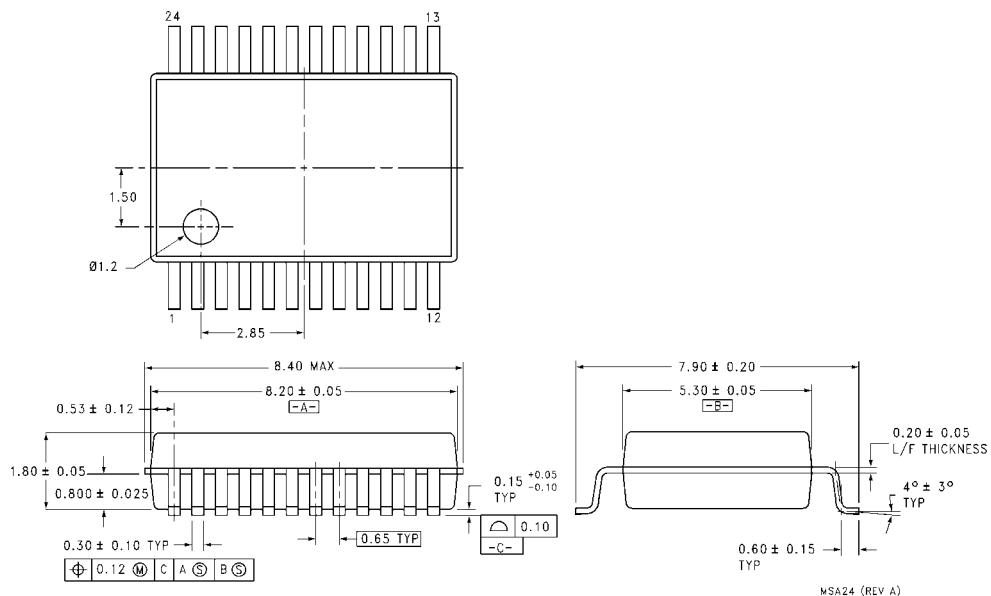
Schematic Diagram Generic for LCX Family



Physical Dimensions inches (millimeters) unless otherwise noted

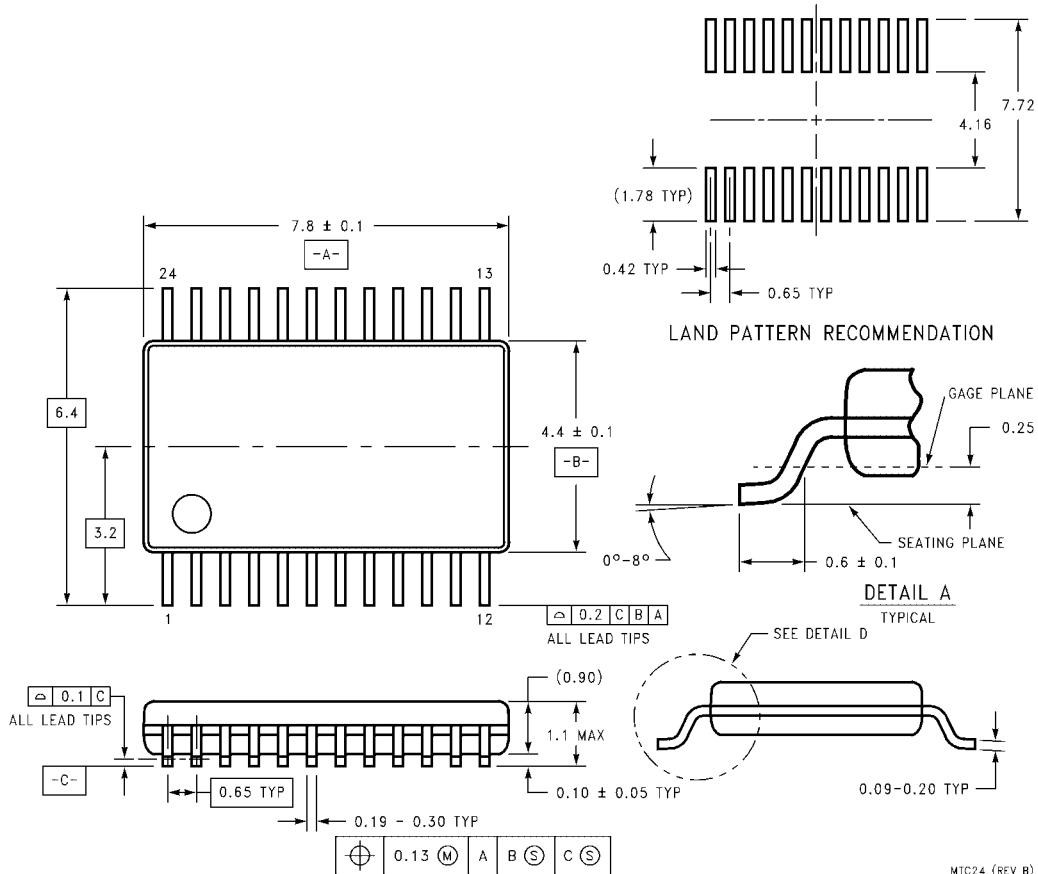


**24-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
Package Number M24B**



**24-Lead Shrink Small Outline Package (SSOP), EIAJ TYPE II, 5.3mm Wide
Package Number MSA24**

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



MTC24 (REV B)

24-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
Package Number MTC24

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